TOSHIBA Field Effect Transistor GaAs N-Channel Dual Gate MES Type

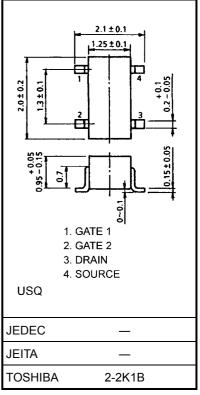
3SK274

TV Tuner, UHF RF Amplifier Applications

Unit: mm

Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Gate 1-drain voltage	V _{G1DO}	-9	V
Gate 2-drain voltage	V _{G2DO}	-9	V
Gate 1-source voltage	V _{G1S}	-4	V
Gate 2-source voltage	V _{G2S}	-4	V
Gate 1 current	I _{G1}	1	mA
Gate 2 current	I _{G2}	1	mA
Power dissipation	P _D	100	mW
Channel temperature	T _{ch}	125	°C
Storage temperature range	T _{stg}	−55~125	°C



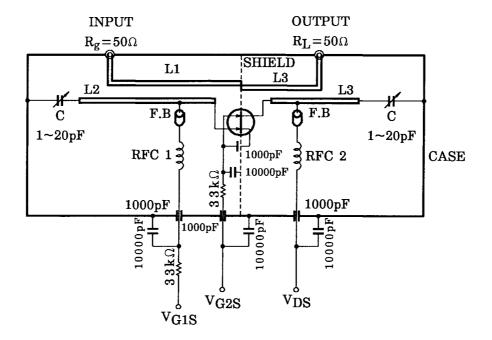
Weight: 0.006 g (typ.)

Electrical Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate 1 leakage current	I _{G1SS}	$V_{DS} = 0$, $V_{G1S} = -3$ V, $V_{G2S} = 0$	_	_	-4	μА
Gate 2 leakage current	I _{G2SS}	$V_{DS} = 0$, $V_{G1S} = 0$, $V_{G2S} = -3 \text{ V}$	_	_	-4	μА
Drain current	I _{DSS}	$V_{DS} = 3 V, V_{G1S} = 0, V_{G2S} = 0$	6	_	20	mA
Gate 1-source cut-off voltage	V _{G1S} (OFF)	$V_{DS} = 3 \text{ V}, V_{G2S} = 0, I_D = 100 \ \mu\text{A}$	-0.7	_	-1.8	V
Gate 2-source cut-off voltage	V _{G2S} (OFF)	$V_{DS} = 3 \text{ V}, V_{G1S} = 0, I_D = 100 \ \mu\text{A}$	-0.7	_	-1.8	V
Forward transfer admittance	Y _{fs}	$V_{DS} = 3 \text{ V}, V_{G2S} = 1 \text{ V}$ $I_D = 5 \text{ mA}, f = 1 \text{ kHz}$	_	19		mS
Input capacitance	C _{iss}	V _{DS} = 3 V, V _{G2S} = 1 V	_	0.6	1.4	pF
Reverse transfer capacitance	C _{rss}	I _D = 5 mA, f = 1 MHz	_	0.013	0.030	pF
Power gain	G _{ps}	$V_{DS} = 3 \text{ V}, V_{G2S} = 1 \text{ V}$	17	20.5	_	dB
Noise figure	NF	I _D = 5 mA, f = 800 MHz (Figure 1)	_	1.0	2.0	dB

Caution

GaAs (Gallium Arsenide) is used in this product. The dust or vapor can be dangerous to humans. Do not break, cut, crush or dissolve chemically. Dispose of this product properly according to law. Do not intermingle with normal industrial or domestic waste.



L1~L4: \(\phi 0.8 \) mm silver plated copper wire

C: Air trimmer TTA25A 200A (MURATA Manufacturing. Co., Ltd.)

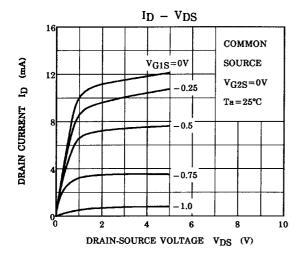
RFC 1: ϕ 0.35 mm UEW 3 mm ID, 7 T RFC 2: ϕ 0.35 mm UEW 3 mm ID, 10 T

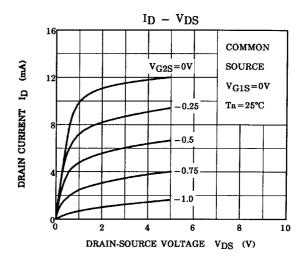
Figure 1 800 MHz Gps, NF Test Circuit

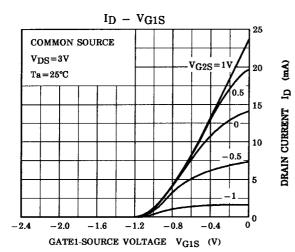
Marking

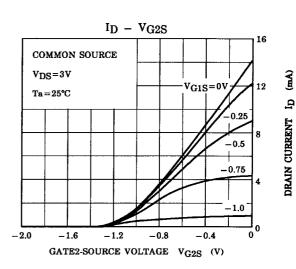


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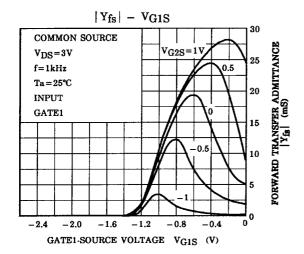


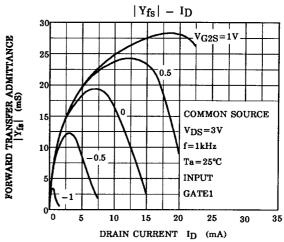


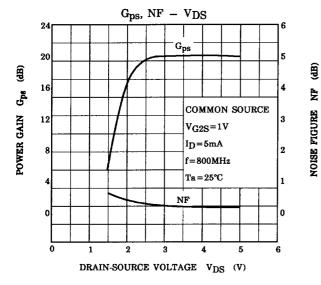


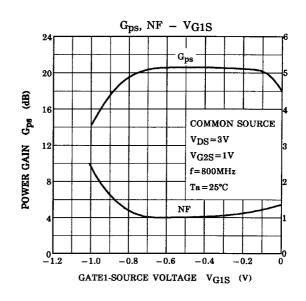
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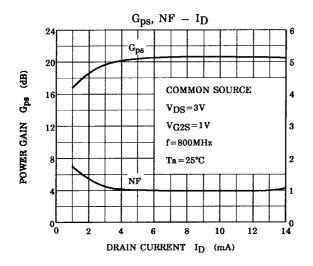


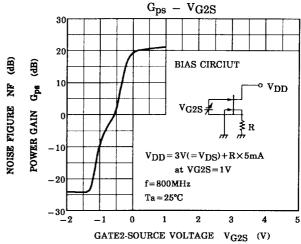


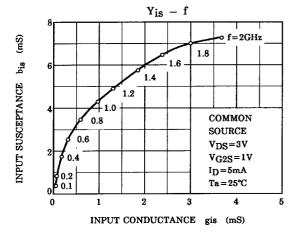
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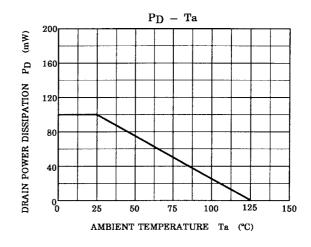
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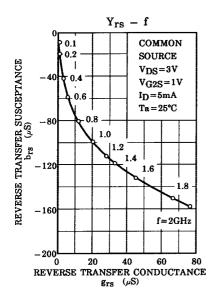
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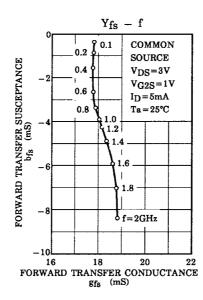




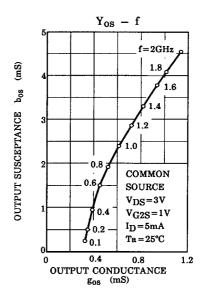








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RESTRICTIONS ON PRODUCT USE

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- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
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